

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT:

Sung Soo Chung, et al.

**SERIAL NO.:** 

09/834,506

FILING DATE:

April 12, 2001

TITLE:

AC COUPLED LINE TESTING USING BOUNDARY SCAN TEST

**METHODOLOGY** 

**EXAMINER:** 

Chaudry, Mujtaba M.

ART UNIT:

2133

## **CERTIFICATE OF MAILING**

I hereby certify that this paper is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Mail Stop Issue Fee, Commissioner for Patents, P.O. Box 1450, Alexandria VA 22313-1450, on the date printed below:

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## APPLICANT'S COMMENTS ON REASONS FOR ALLOWANCE

These comments are responsive to the Notice of Allowance mailed on September 22, 2006, which sets forth the Examiner's statement of reasons for allowance.

The Examiner is thanked for the kind allowance of all pending claims (i.e., claims 1-8, 13 and 27-30). Applicants acknowledge the Examiner's statement of reasons for allowance as set forth in the Notice of Allowance. However, Applicants point out that the reasons for allowability of the above referenced claims are not limited to the reasons for allowance as set forth in the Notice of Allowance, and that additional reasons for

allowability may exist, each of which may be independently sufficient to establish the patentability of one or more pending claims.

Applicants respectfully reserve the right to introduce, articulate, or otherwise comment on any such additional reasons for allowance as may be appropriate in any future proceedings concerning the claimed invention.

Please charge any additional required fee or credit any overpayment to our deposit account number 50-1698.

Respectfully submitted,

THELEN REID & PRIEST, LLP

Dated: 12-11-06

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